# APPROVAL SHEET

 Customer Name
 :

 Customer P/N
 :

 Frequency
 : 4.000000
 MHz

 Aker Approved P/N
 : SMAN-004000-3-D4-00

 Aker MPN
 : SMAN-004000-3-D4-00

 Rev.
 : 1

 ISSUE DATE
 : Feb.10.2023

APPROVED	CHECKED	PREPARED
Lei		Jing
APPROVED BY CUST	OMER	

# AKER TECHNOLOGY CO., LTD.

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**RoHS** compliant



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APPROVED	:	Xtal	SHEET: 1 of 10		
PREPARED	:	JLING	REV . : 1		
			Confidential		

Rev.	Date	Reviser	Revise contents
1	2023/2/10	JLING	Initial Released



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APPROVED :	Xtal	SHEET: 2 of 10		
PREPARED :	JLING	REV . : 1		
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## SMD CRYSTAL OSCILLATOR

#### 1. ELECTRICAL CHARACTERISTICS

■ Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature: 25±5°C

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature: 25±3°C

Relative humidity : 40%~70%

■ AKER Model: SMAN-321

■ Cutting Mode : AT CUT

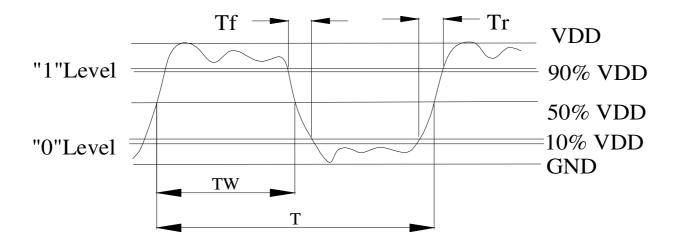
		Electrical Spec				
Parameters	Symbol	Min.	Typ.	Max.	Units.	Notes
Nominal Frequency		2	4.000000	)	MHz	
Frequency Stability			±50		ppm	
Supply Voltage	$V_{CC}$		3.3±10%		V	
Output Load CMOS	CL			15	pF	
Aging			±3		ppm	First Year
Enable Control			Yes			Pad 1
Operating Temperature		-40	25	85	$^{\circ}\mathbb{C}$	
Storage Temperature Range		-55	~	125	$^{\circ}$ C	
Output Voltage High	VoH	90%V <sub>DD</sub>			V	
Output Voltage Low	VoL			10%VDD	V	
Input Current	Icc			7	mA	
Standby Current	Ist			10	μA	
Rise Time	Tr			5	ns	10%~90%V <sub>DD</sub> Level
Fall Time	Tf			5	ns	90%~10%V <sub>DD</sub> Level
Symmetry (Duty ratio)	TH/T	45	~	55	%	
Start-up Time	Tosc			10	ms	
Enable Voltage High	Vhi	70%V <sub>DD</sub>			V	
Disable Voltage Low	Vlo			30%VDD	V	
Output Enable Delay Time	T on			10	ms	
Output Disable Delay Time	T off			200	ns	

<sup>\*</sup>Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.\*

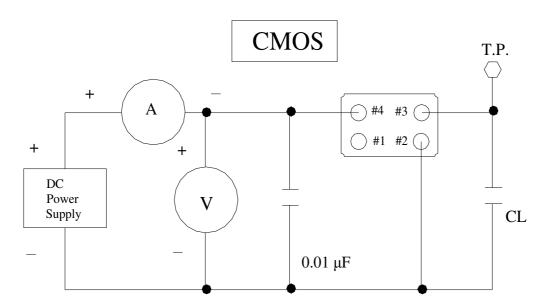


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#### 2. C-MOS LOAD OUTPUT WAVEFORM



#### 3. C-MOS LOAD TEST CIRCUIT

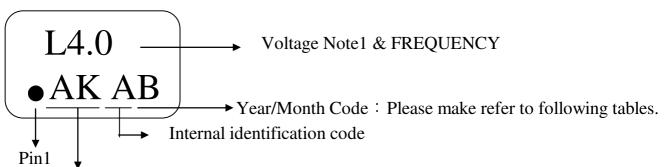


\*\*\*Because SMA series has no by pass capacitor. So,we recommend our customer to use capacitor 0.01  $\mu F$  in join Vcc and GND.



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#### 4. MARKING:



#### NOTE1:

NOIDI.	
T	5.0V TTL
С	4.5~5.0V CMOS
L	2.97~3.63V TTL&CMOS
R	2.8~3.0V CMOS
S	2.25~2.75V CMOS
Y	1.5~2.0V CMOS
Z	0.8~1.4V CMOS
W	Voltage Range CMOS

AKER LOGO.

#### Date Code Guide

Year	2021	2022	2023	2024
	2025	2026	2027	2028
Month	(4N+1)	(4N+2)	(4N+3)	(4N+0)
JAN	a	n	Α	N
FEB	ь	p	В	P
Mar	С	q	C	Q
Apr	d	r	D	R
May	е	S	E	S
Jun	f	t	F	T
Jul	හා	u	G	U
Aug	h	v	H	V
Sep	j	w	J	W
Oct	k	X	K	X
Nov	1	у	L	Y
Dec	m	Z	M	Z

A cycle every four years

#### 5. DIMENSION:

#### Enable / Disable Function

E/D (#1)	OUTPUT (#3)
HIGH (Open)	Operating
LOW	High impedance

# Open) Operating High impedance AKE

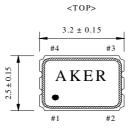
#### PIN FUNCTION

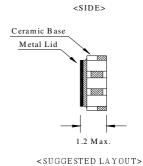
#1: Enable / Disable Control

#2 : GND

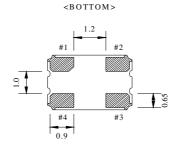
#3: OUTPUT

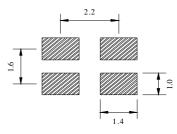
#4: VDD





(UNIT:mm)

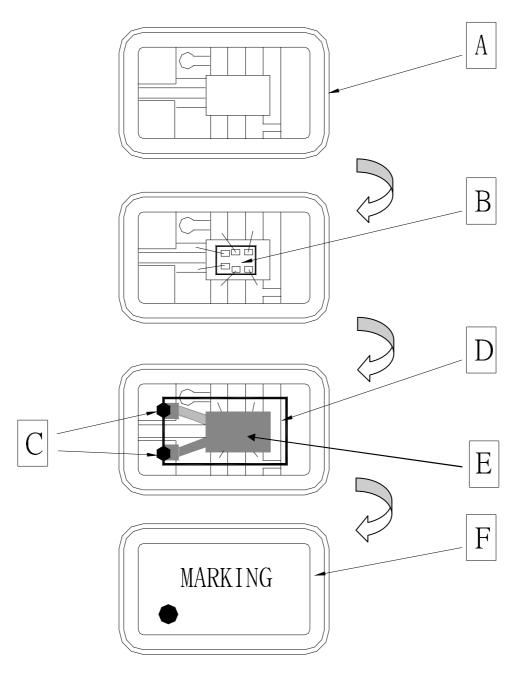






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# 6. STRUCTURE ILLUSTRATION



COMPONENTS		MATERIALS	CO:	MPONENTS	MATERIALS
A	Base (Package)	Ceramic (Al2O3)+Kovar (Fe/Co/Ni)	D	Crystal blank	SiO <sub>2</sub>
В	IC chip		E	Electrode	Cr / Ag
С	Conductive adhesive	Ag / Silicon resin	F	Lid	Fe/Co/Ni

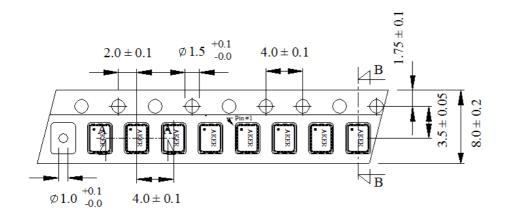


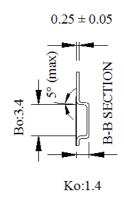
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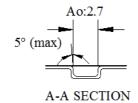
#### 7. PACKING:

#### TAPE SPECIFICATION

(Unit:mm)



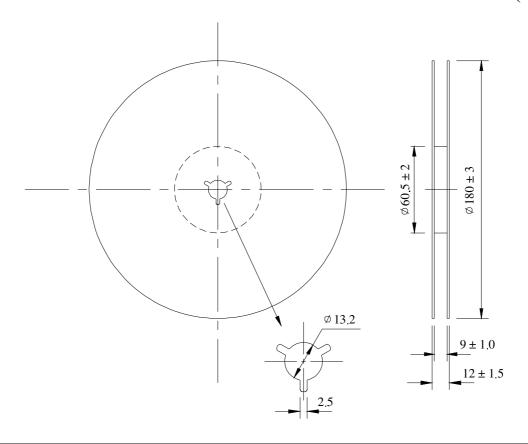




Feeding

#### **OUTLINE DIMENSION**

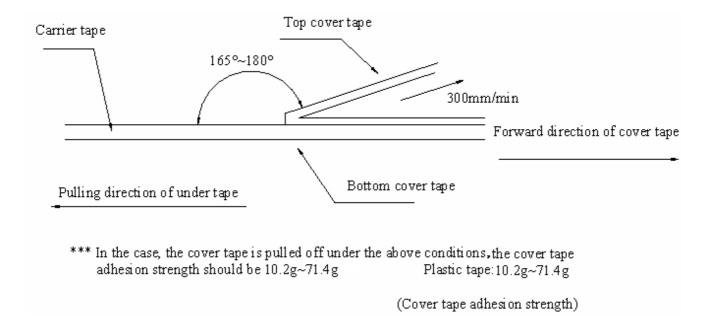
(Unit:mm)



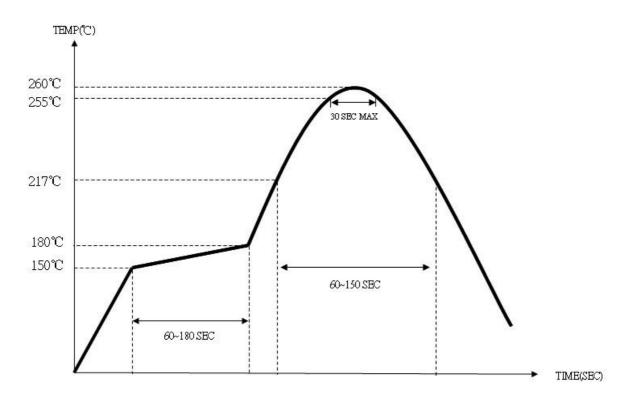


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#### 8. COVER TAPE ADHESION STRENGTH:



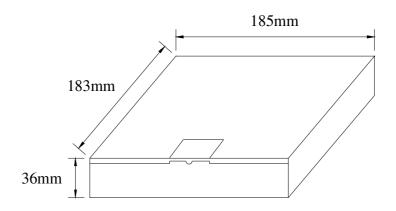
#### 9. SOLDERING REFLOW PROFILE





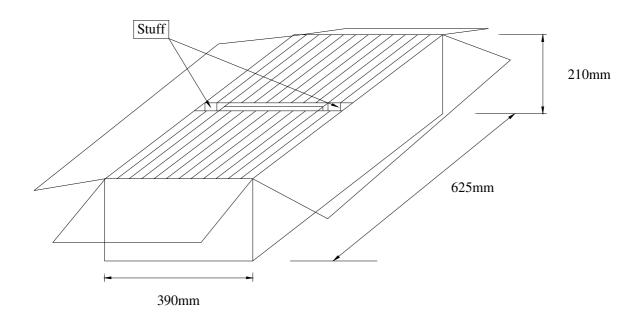
Aker Approved P	/N :	SMAN-00	)4000-3-D4-00
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## 10. PACKING:



BOX = 3000 PCS / REEL(MAX)





SMD product packs 32 BOX=The outside box packs (3000 PCS \* 32 BOX = 96000 PCS)(MAX)



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#### 11. MECHANICAL PERFORMANCE

11. MECHA	NICAL PERFORMANCE	
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a hight of 75 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness.  ( in accordance with JIS-C0044 )	
11.2 Vibration Test	The specimen is measured for its frequency before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range; 20~2000HZ Peak to peak amplitude: 1.52 mm Peak acceleration: 20G Sweep time: 20 minute / axis Pendicular total test time: 4 hours	To satisfy the electrical performance.
11.3 Resistance to Soldering Test	( in accordance with MIL-STD-883F: 2007.3 )  The specimen is measured for its frequency before the test. Place the specimen on the belt of the converynace and let it pass through the reflow with the presetted temperature condition.  After passing twice the reflow place, the specimen under the referee condition for -~2 hours and then measure its electrical performance.  Temperature Condition of IR Simulation:  The temperature range of the preheated section is setted at 150~180°C for 60~120 sec. For the next section the temperature range is setted at 217~260°C for 45~90 sec. and within this time range the specimen should be able to sustain at the peak temperature, 260+/-3°C , for 10 sec long.  ( in accordance with JESD22-B106-B )	
11.4 Fine Leak Test	Place the specimen in a pressurized container and pressurize it with the detection gas (mixed gas consisting of 95% or more helium) for at least 2 hours. Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container.  ( in accordance with MIL-STD-883F: 1014.11 )  The referee condition.  Temperature $25 \pm 2 \degree C$ Humidity $44 \sim 55 \%$ Pressure $86 \sim 106 \text{ kPa}$	Less than 1.0 * 10 -8 atm .c.c. / sec, Helium
	( in accordance with MIL-STD-883E:1014.9 )	



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# 12. CLIMATIC RESISTANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	The specimen is measured for its frequency before the test.  Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours. Take the specimen out of the chamber and measure itselectrical performance after leaving $1 \sim 2$ hours under the referee condition. (in accordance with JIS-C0020)	FERIORIVIANCE
12.2 Aging Test	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and keep it at the temperature of $+125 \pm 3^{\circ}$ C for $720 \pm 48$ hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for $1 \sim 2$ hours under the referee condition . ( in accordance with JIS-C0021 )	To satisfy the electrical performance .
12.3 High Temperature & High Humidty	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and kept it at the temperature of $+85\pm5$ °C and humidity of $85\pm5$ % for $168\pm6$ hours.and then take the specimen out and measure its electrical performance after leaving for $1\sim2$ hours under the referee condition. ( in accordance with MIL-STD-883F: 1004.7 )	
12.4 Temperature Cycle Test	The specimen is measured for its frequency before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + 125 $\pm$ 3 °C (15 $\pm$ 3 min).    Low temp55 $\pm$ 3 °C (15 $\pm$ 3 min).    Measure its electrical performance after leaving it for 1 $\sim$ 2 hours under the referee condition . ( in accordance with MIL-STD-883F: 1010.8 )	